



IGBT Power Module 1200V/150A

Features

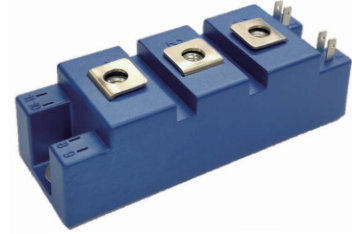
- ◆ 34mm Fast Switching Trench / Field Stop IGBT Technology
- ◆ Low Switching Losses
- ◆ Super Fast Diodes
- ◆ High Short Circuit Capability

Preliminary

Applications

- ◆ Welder / Power Supply
- ◆ UPS / Inverter
- ◆ Industrial Motor Drive

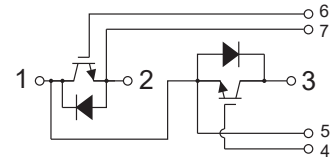
HD-9434



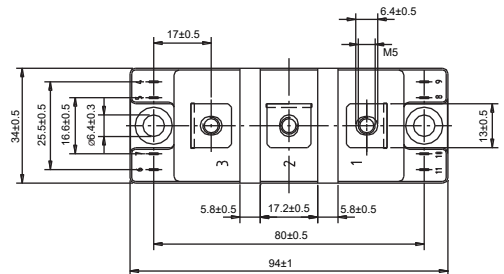
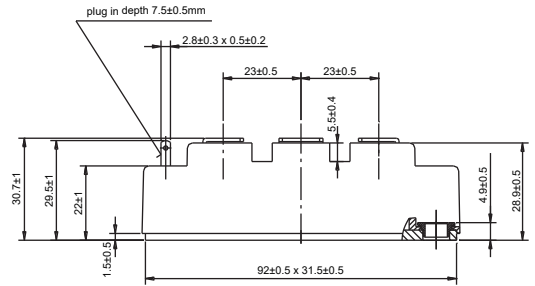
Maximum Ratings (T_C=25°C)

Item	Symbol	Rated Value	Unit
Collector-Emitter Voltage	T _{VJ} = 25°C V _{CES}	1200	V
Gate-Emitter Peak Voltage	V _{GES}	±20	V
Continuous DC Collector Current	T _C = 100°C I _{C,nom.}	150	A
Repetitive Peak Collector Current	t _p = 1ms I _{CRM}	300	A
Total Power Dissipation	P _{tot}	790	W
Isolation Voltage	RMS, f=50Hz, t=1min V _{iso}	3000	V
Continuous DC Forward Current	I _F	150	A
Repetitive Peak Forward Current	t _p = 1ms I _{FRM}	300	A
Temperature under switching conditions	T _{VJ op}	-40~+150	°C
Storage Temperature	T _{stg}	-40~+125	°C
Mounting Torque	Module Base to Heatsink (M6)	3~5	N.m
	Busbar to Terminal (M5)	2.5~5	

Circuit Diagram Headline



Package Outlines



Dimensions in mm (1 mm = 0.0394")



■ Electrical Characteristics ($T_{vj} = 25^{\circ}\text{C}$)

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Collector-emitter saturation voltage	$V_{CE\text{ sat}}$	$I_C = 150\text{A}, V_{GE} = 15\text{V}$ $T_{vj} = 25^{\circ}\text{C}$		1.75	2.15	V
		$I_C = 150\text{A}, V_{GE} = 15\text{V}$ $T_{vj} = 125^{\circ}\text{C}$		2.05		
		$I_C = 150\text{A}, V_{GE} = 15\text{V}$ $T_{vj} = 150^{\circ}\text{C}$		2.1		
Gate threshold voltage	V_{GEth}	$I_C = 5.3\text{mA}, V_{CE} = V_{GE}, T_{vj} = 25^{\circ}\text{C}$	5.8	6.4	6.9	V
Gate charge	Q_G	$V_{GE} = -15\text{V} \dots +15\text{V}$		1.7		μC
Internal gate resistor	R_{Gint}	$T_{vj} = 25^{\circ}\text{C}$		1		Ω
Input capacitance	C_{ies}	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		26.438		nF
Output capacitance	C_{oes}	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		0.653		nF
Reverse transfer capacitance	C_{res}	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		0.382		nF
Collector-emitter cut-off current	I_{CES}	$V_{CE} = 1200\text{V}, V_{GE} = 0\text{V}, T_{vj} = 25^{\circ}\text{C}$			1	mA
Gate-emitter leakage current	I_{GES}	$V_{CE} = 0\text{V}, V_{GE} = 20\text{V}, T_{vj} = 25^{\circ}\text{C}$			100	nA
Turn-on delay time, inductive load	$t_{d\text{ on}}$	$I_C = 150\text{A}, V_{CE} = 600\text{V}$ $T_{vj} = 25^{\circ}\text{C}$		0.144		μs
		$V_{GE} = \pm 15\text{V}$ $T_{vj} = 125^{\circ}\text{C}$		0.149		
		$R_{Gon} = 1.1\Omega$ $T_{vj} = 150^{\circ}\text{C}$		0.27		
Rise time, inductive load	t_r	$I_C = 150\text{A}, V_{CE} = 600\text{V}$ $T_{vj} = 25^{\circ}\text{C}$		0.05		μs
		$V_{GE} = \pm 15\text{V}$ $T_{vj} = 125^{\circ}\text{C}$		0.054		
		$R_{Gon} = 1.1\Omega$ $T_{vj} = 150^{\circ}\text{C}$		0.06		
Turn-off delay time, inductive load	$t_{d\text{ off}}$	$I_C = 150\text{A}, V_{CE} = 600\text{V}$ $T_{vj} = 25^{\circ}\text{C}$		0.274		μs
		$V_{GE} = \pm 15\text{V}$ $T_{vj} = 125^{\circ}\text{C}$		0.296		
		$R_{Goff} = 1.1\Omega$ $T_{vj} = 150^{\circ}\text{C}$		0.5		
Fall time, inductive load	t_f	$I_C = 150\text{A}, V_{CE} = 600\text{V}$ $T_{vj} = 25^{\circ}\text{C}$		0.102		μs
		$V_{GE} = \pm 15\text{V}$ $T_{vj} = 125^{\circ}\text{C}$		0.17		
		$R_{Goff} = 1.1\Omega$ $T_{vj} = 150^{\circ}\text{C}$		0.21		
Turn-on energy loss per pulse	E_{on}	$I_C = 150\text{A}, V_{CE} = 600\text{V}, L_S = 30\text{nH}$ $T_{vj} = 25^{\circ}\text{C}$		4.02		mJ
		$V_{GE} = \pm 15\text{V}, di/dt = 3400\text{A}/\mu\text{s} (T_{vj} = 150^{\circ}\text{C})$ $T_{vj} = 125^{\circ}\text{C}$		7.85		
		$R_{Gon} = 1.1\Omega$ $T_{vj} = 150^{\circ}\text{C}$		10.80		
Turn-off energy loss per pulse	E_{off}	$I_C = 150\text{A}, V_{CE} = 600\text{V}, L_S = 30\text{nH}$ $T_{vj} = 25^{\circ}\text{C}$		11.67		mJ
		$V_{GE} = \pm 15\text{V}, du/dt = 3300\text{V}/\mu\text{s} (T_{vj} = 150^{\circ}\text{C})$ $T_{vj} = 125^{\circ}\text{C}$		15.65		
		$R_{Goff} = 1.1\Omega$ $T_{vj} = 150^{\circ}\text{C}$		17.65		
SC data	I_{SC}	$V_{GE} \leq 15\text{V}, V_{CC} = 800\text{V}$ $V_{CEmax} = V_{CES} - L_{sCE} \cdot di/dt$ $t_p \leq 10\mu\text{s},$ $T_{vj} = 150^{\circ}\text{C}$		600		A
Thermal resistance, junction to case	R_{thJC}	per IGBT			0.19	$^{\circ}\text{C}/\text{W}$
Thermal resistance, case to heatsink	R_{thCH}	per IGBT		0.081		$^{\circ}\text{C}/\text{W}$
External gate resistance	R_{Gext}	$T_{vj} = 25^{\circ}\text{C}$	1.1		10	Ω



■ Diode Ratings & Characteristics

Characteristics	Symbol	Test Conditions	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	$T_{vj} = 25^{\circ}C$	1200	V
Continuous DC forward current	I_F		150	A
Repetitive peak forward current	I_{FRM}	$t_p = 1ms$	300	A
I^2t - value	I^2t	$V_R = 0V, t_p = 10ms, T_{vj} = 125^{\circ}C$	4100	A ² s
		$V_R = 0V, t_p = 10ms, T_{vj} = 150^{\circ}C$	4000	

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward voltage	V_F	$I_F = 150A, V_{GE} = 0V$ $T_{vj} = 25^{\circ}C$		2	2.5	V
		$I_F = 150A, V_{GE} = 0V$ $T_{vj} = 125^{\circ}C$		1.9		
		$I_F = 150A, V_{GE} = 0V$ $T_{vj} = 150^{\circ}C$		1.85		
Peak reverse recovery current	I_{RM}	$I_F = 150A, -di_F/dt = 3400A/\mu s$ ($T_{vj} = 150^{\circ}C$) $T_{vj} = 25^{\circ}C$		120		A
		$V_R = 600V$ $T_{vj} = 125^{\circ}C$		170		
		$V_{GE} = -15V$ $T_{vj} = 150^{\circ}C$		180		
Recovered charge	Q_R	$I_F = 150A, -di_F/dt = 3400A/\mu s$ ($T_{vj} = 150^{\circ}C$) $T_{vj} = 25^{\circ}C$		9.08		μC
		$V_R = 600V$ $T_{vj} = 125^{\circ}C$		20.0		
		$V_{GE} = -15V$ $T_{vj} = 150^{\circ}C$		23.9		
Reverse recovery energy	Erec	$I_F = 150A, -di_F/dt = 3400A/\mu s$ ($T_{vj} = 150^{\circ}C$) $T_{vj} = 25^{\circ}C$		7.68		mJ
		$V_R = 600V$ $T_{vj} = 125^{\circ}C$		13.29		
		$V_{GE} = -15V$ $T_{vj} = 150^{\circ}C$		15.0		
Reverse Recovery Time	T_{rr}	$I_F = 150A, -di_F/dt = 3400A/\mu s, V_R = 600V, V_{GE} = -15V, T_{vj} = 25^{\circ}C$		88		ns
Thermal resistance, junction to case	R_{thJC}	per diode			0.31	$^{\circ}C/W$
Thermal resistance, case to heatsink	R_{thCH}	per diode		0.13		$^{\circ}C/W$
Temperature under switching conditions	$T_{vj op}$		-40		150	$^{\circ}C$

■ Module Ratings & Characteristics

Characteristics	Symbol	Test Conditions	Value	Unit
Material of module baseplate			Cu	
Internal isolation		basic insulation (class 1, IEC 61140)	Al_2O_3	
Creepage distance		terminal to heatsink	17	mm
		terminal to terminal	20	
Clearance		terminal to heatsink	17	mm
		terminal to terminal	9.5	
Comperative tracking index	CTI		>200	



Typical Characteristics

Preliminary Data

Fig.1 Output characteristic IGBT, Inverter (typical)

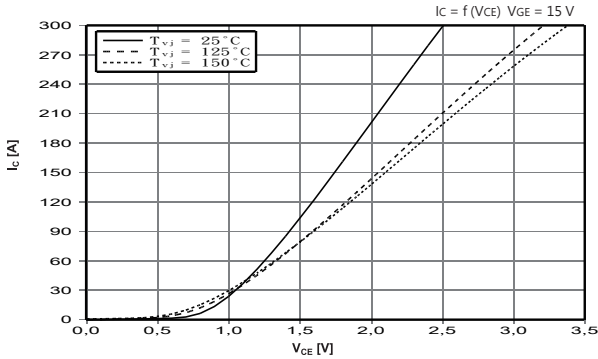


Fig.2 Output characteristic IGBT, Inverter (typical)

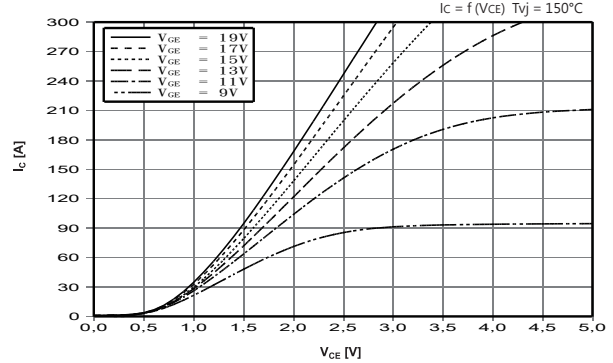


Fig.3 Transfer characteristic IGBT, Inverter (typical)

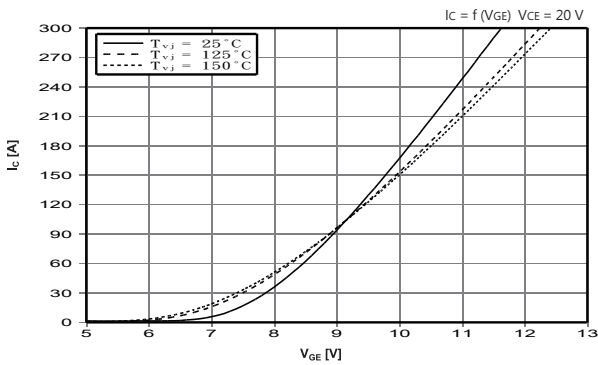


Fig.4 Switching losses IGBT, Inverter (typical)

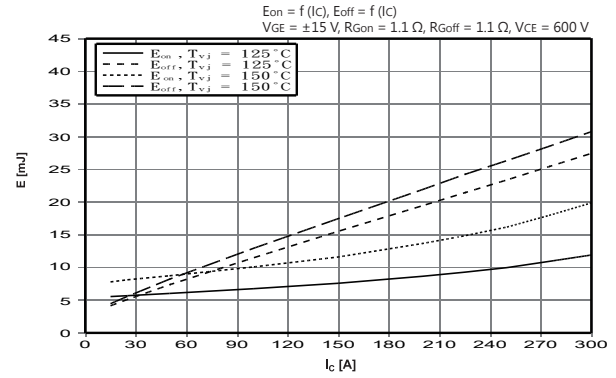


Fig.5 Switching losses IGBT, Inverter (typical)

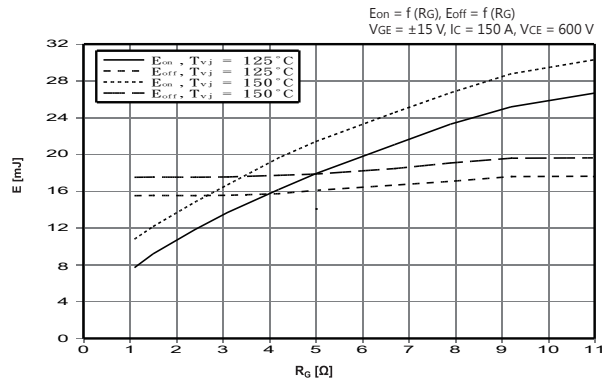


Fig.6 Transient thermal impedance IGBT, Inverter

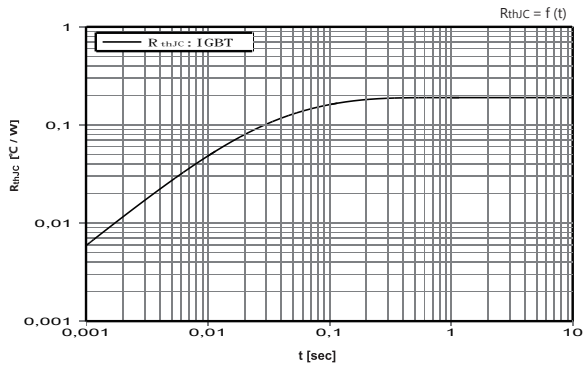


Fig.7 Reverse bias safe operating area IGBT, Inverter (RBSOA)

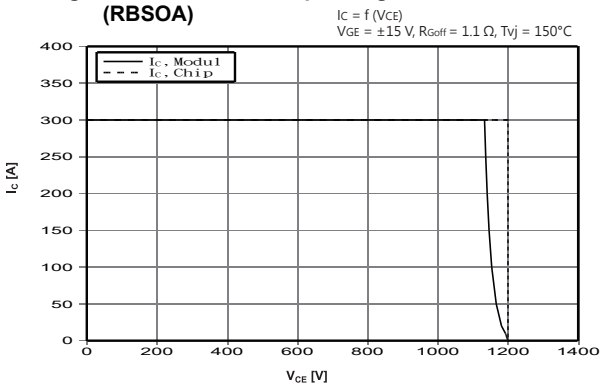
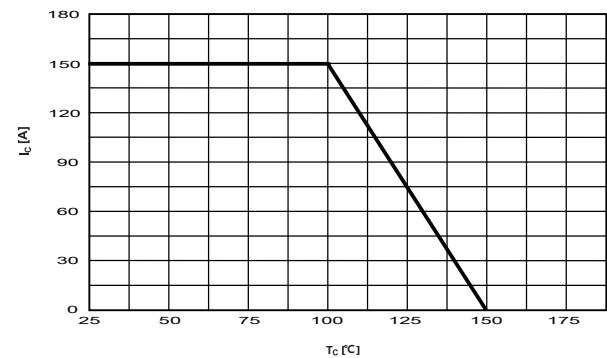


Fig.8 Output characteristic IGBT, Inverter (typical)





Typical Characteristics

Preliminary Data

Fig.9 Switching losses Diode, Inverter (typical)

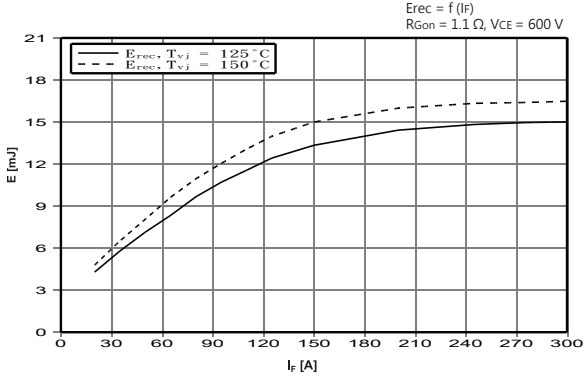


Fig.10 Switching losses Diode, Inverter (typical)

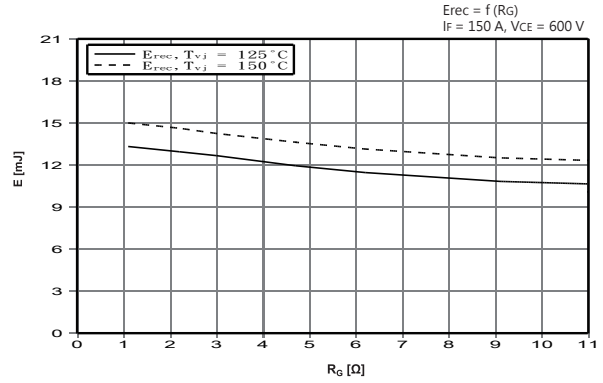


Fig.11 Transient thermal impedance Diode, Inverter

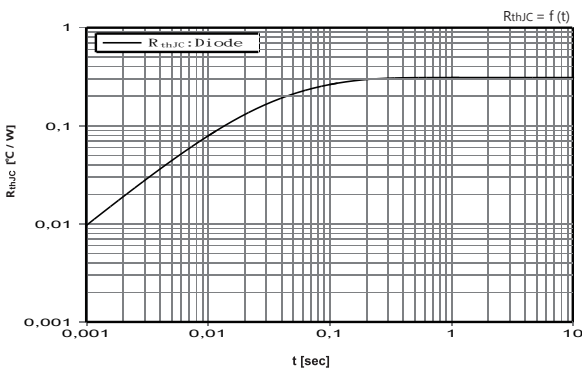
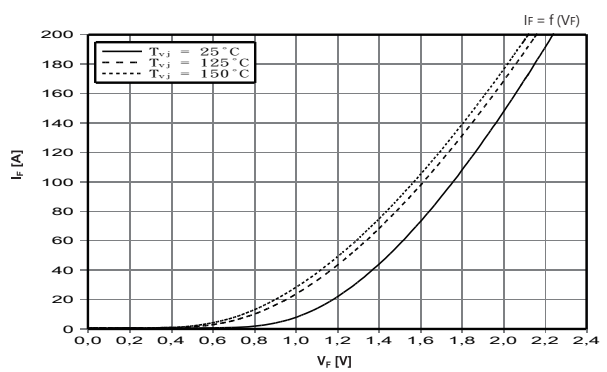


Fig.12 Forward characteristic of Diode, Inverter (typical)





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